Customer:	<u>No. KK-2002-1259</u>
	<u>Date: May. 07, 2002</u>
Attention:	
Your ref. No:	
Your Part. No:	

SPECIFICATIONS

ALPS';

MODEL (100kAX 2)

Spec. No.:

Sample No.: G66643170

RECEIPT STATUS
RECEIVED
By Date
Signature
Name
Title

ALPS ELECTRIC CO., LTD.

HEAD OFFICE 1-7, YUK I GAYA-OHTSUKA-CHO, OHTA-KU, TOKYO 145-8501 JAPAN Sales

24678

SPECIFICATIONS

- 1. THIS SPECIFICATIONS APPLY TO RK50112A0004 POTENTIOMETER.
- 2. CONTENTS OF THIS SPECIFICATIONS.

4K5021-2 K50210001

3. MARKING

•MARKING ON ALL UNITS
DATE CODE, RESIST. VALUE, TAPER

4. REMARKS

•FURNISH PACKAGE NUT: 1, WASHER: 1 (H=14)

· NOTES

•Marking \Rightarrow in specifications shows standard and condition for application.

·CAUTION

Regardless of the suggested applications of these products being introduced in the specifications, when using them for equipment and devices requiring a high degree of safety, respective manufacturers will please preserve safety of the planned equipment and devices by providing necessary protective circuits and redundancy circuits and reconfirm if safety is being duly preserved.

Products being introduced in the specifications have been designed and manufactured for applications to ordinary electronic equipment and devices such as the AV equipment, electric home appliances, office machines and communications equipment. Consequently, when employing these products for applications requiring a high degree of safety and reliability such as the medical equipment, aviation and aircraft equipment, space equipment and burglar alarm equipment, the using manufacturers will please thoroughly study the proprieties of these products for the planned applications.

Although we are exerting our best efforts to maintain the quality of these products, we cannot guarantee that they will never cause short circuiting and open circuitry. Therefore, when designing an equipment or device with whitch the priority is given to the safety, you will please carefully study the influences to the whole equipment of a single function failure of Potentiometers and Encoders in advance to make out a fail-safe design providing.

1. Scope **海爾**班

This specification applies to potentiometer with carbon composition resistor, used in electronic equipment. この仕事は電子機器・搬工用いちれる映象系統体を用いた可変が機器とついて規定する。

Rotational (_____ shaft . _____ story .)

2. construction 精造 2. 1 Dimensions and materials

Refer to the attached

寸法・材料

3)基参数

					AU	BAL	PS El	LECTRIC CO., LTD.
					AP 7-828 34.6. 7	CHKD 1-版2	DSGD.	TITLE ROTATIONAL POTENTIOMETER 回転阿克斯克器
SYMB	DATE	APPD	CHKD	DSGD	佐藤	94.6.06	94.6.03	DOCUMENT NO. 4 K 5 0 2 1 - 2

94. 04. 25

3. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests is as follows:

Ambient temperature : 150 to 350 Relative humidity : 25% to 85% Air pressure : 86kPa to 106kPa

If there is any doubt about the results. measurements

shall be made within the following limits:

Ambient temperature : 20±10 Relative humidity : 63% to 73% Air pressure : 86kPa to 106kPa

Temperature for operating and storage

Dimensions: See attached drawing Operating temperature: -10°C-+70°C Storage temperature: -20°C~+80°C 〇標準状態

特に指定がない限り測定は常温(温度15~35℃)。常湿 (湿度25~85%),常知王(知正86~106kPa)にて行う。

ただし、判定に疑義を生じた場合は温度20±1℃、湿度 63~73%. 知E86~106kPaにて行う。

○一般性能

形状、寸法は組立図による、

使用温度範囲:-10°C~+70°C 保存温度範囲:-20°C~+80°C

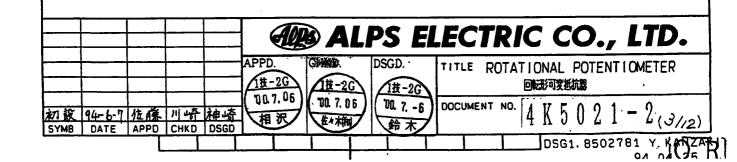
3.1 Mechanical characteristics

٠.	1 Mechanical ci			6	4:000
	Item		Conditions	Specifica 規	tions 格
1	項目 Total mechanical rotation 全回転角度	Angle of effec 有效回忆角度	条 件 tive rotation	300. ;	
			Standard atmospheric conditions 常温15°C to 35°C	28±15	mN - m
2	Rotational torque 回転トルク	Rotational speed 回忆速度 S 60°/钟	0 £=5.C	100 mN·m	or less
		00 7 17	+50 ℃±2°C	13 mN·m	or more
3	Terminal strength 能子波度	for 10 s in a	i of 5 N Shall be applied to the terminals any direction. 時間重を10対電加スた後期定する。	Without excess terminals or p 客いガタ. および接 ないこと.	oor contact
4	End stop strength ストッパー強度	be applied to	g torsion moment load of 1.5Nm shall the shaft for 10s at both ends. Dネジリモーメントを西蘇末にそれぞれ10対面	without dama play in. sha abnormality rotational t Electrical characterist be satisfied 回転トルク、軸の方が	ift. No in corque. ics shall i. タ・回転角度に
5	Bending or play in shaft 軸の曲りおよびガタ	point5 mm from to the axis 動先端より5mm の	pad of 100mN·m shall be applied at the the the the tip of the shaft in a direction perpendicular 位置に100mN・mのモーメントを軸と直角にする。但し反対位置からもモーメントを加え両方の値をたすこととする。	異常がなく電気的特性 Shaft length 軸長(mm) 20 25 30 35	mm D-D or less 両側(mm) 0.2以下 0.25以下 0.3以下 0.35以下
				40	0. 4以下

		ALPS ELECTRIC CO., LTD.
		APPD. CHKD. DSGD. TITLE ROTATIONAL POTENTIOMETER 1按-2G 1按-2G 1按-2G 回航河東抵抗器
初設94-8-30 佐藤川 SYMB DATE APPD C	山崎 神崎 CHKD DSGD	10.7.06 10.7.06 10.76 DOCUMENT NO. 4 K 5 0 2 1 - 2 (2//2)
		DSG1. 8502781 Y. KANZ

94. 04 (2)

	I tem 項目	Conditions 条 件	Specifications 規 格
6	Thrust and tensile shaft 軸の押しおよび 号牒り強度	Thrust and tensile static load of 150N Shall be applied to the shaft in the axial directions for 10 s. 軸の押し方向および号限方向に150Nの移首要を10特別的なる。	Without damage to, or play in, shaft. No abnormality in rotational torque Electrical characteristics shall be satisfied. 動の方字、および解集 回転トルクに 異常がなく。 電気管理能を満足すること。
7	Nut tightening strength ナット締付強度	Installation torque of 2N-mi shall be applied to tighten the nut. However, the upper part of the nut shall be set 1.0mm or more lower than upper part of the bushing. 2N・mのトルクでナットを繰付ける。をだし、ナット上部が確定け上部より1.0mm 以上沈九だ状態で使用されている場合とする。	Rotational torque shall be 120% or less before nut is tightened. The difference between maximum and minimum value in the same direction. shall be 5 mN·m(51 of·cm) or less. Without rotational deviation. 回転トルフはナット総付け前の120%以下。また同一方向で表大と最大の差は 7 mN·m以外とし回転公方を集め起じてと。



			· /
3	.2 Electrical c	haracteristics Trails	_
	!tem 項目	Conditions 条 件	Specifications 規 核
1	Nominal total resistance and tolerance 公特全抵抗値 および軒容差	The resistances between terminals 1and 3 shall be measured 鶴子1. 3扇の抵抗値を測定する。	100Kn±20%
2	Resistance law 抵抗変化特性	Measurement shall be made by the resistance law method: For other procedures, refer to IEC Pub. 393-1. 電圧起て測定。その他 JIS C 5261 に準拠する。	15A カーブ Refer to the attached 別紙等席
3	Power rating 定格之力	Power rating is based on continuous full load operation at the maximum voltage between terminals 1 and 3 Power rating vs. ambient temperature shall be denoted on the following graph. 端子1と3の高で連続時間することが出来る最大電力。 関西国家区対する。 電力家連絡は下区とする。	0. 1 w
4	Rated voltage 定格包王	Rated voltage E= ✓PR Maximum operating voltage 定接受圧 Where P: Power rating (W) 定接受力 R: 公特全性抗菌 when the rated voltage exceeds the maximum operating voltage. the maximum operating voltage shall be the rated voltage(For a.c. only をだし、定接受工力場高使用電子を超える場合は、この最高使用電子を定接電圧とする。(交換期)	150 v a.c.
5	Resistance- temperature characteristic 抵抗温度耕生	The potentiometer shall be maintained in a thermostatic chamber at a temperature of 70±3 t without electrical load for 5h. after which the total resistance shall be measured immediately. 温度 70±3℃の恒温信中に無負荷で5時間設置性、ただちにそままの状態で、全抵抗値を測定する。	Change in total resistance is relative to the value before test 全抵抗値の変化は +5 % 初期組合対して -20

					A	BA	LPS E	LEC'	TRIC CO.,	LTD.
					APPD.	CHKO. 1-安2 94.6.06	DSGD. 1一款 2	ł	回転形河変抵抗器	[OMETER
SYMB	DATE	APPD	CHKD	DSGD	94.6. 7	VIII /	94.6.03	DOCUME	NT NO. 4 K 5 0 2 1	- 2 (4/12)
		L	l						DSG1. 8502	781 Y. KANZAK 94. 04. 25

	item 順	Conditions 条	Specifications 現 格
6	Attenuation and insertion loss 最大演奏量と 挿入相失	The attenuation and insertion loss at each end of Angle of effect rotation shall be measured. And the attenation and insertion loss shall be induced from the first unite. when the A.C.10V is applied between terminals 1 and 3 and the securite by frequency of 10KHZ astro-table (10KHZ)	Total resistance 全核值 是大漢表量 less than or less 10kQ未満 -110dB以下 or more or less 10kQ以上 -120dB以下 Total resistance loss 全核值 挿入網失 less than or less 10kQ未満 -2dB以下 or more or less
7	Jump-off resistance 跳 羅	When the moving contact passes from the silver area to the resistance area. the magnitude of change caused by this sudden change in voltage shall be measured. ***********************************	10k以上 -1dB以下 0.01% or less of the nominal voltage. EMINETO 0.01%以下。
8	Sudden change in voltage 逆 行	5 V d.c. shall be applied to the terminals between 1 and 3 and the following jump-off voltage shall be measured.	0.01% or less of the nominal voltage. 印加電圧の 0.01%以下。
9	No ise 酒味音	20 V d.c. when the rated voltage is 20 V or less. its rated voltage shall be applied to the terminals between 1 and 3. And then the noise shall be measured by the specified speed. 出子1一3間之意的第三名の(文化が20V以下の時は、その第三)を加えてのときに発生する概念を正を表する。 Shaft rotation rotations/min 30 回 分 For other procedures, refer to IEC Pub. 393-1-6. Test Method A. その他 JIS C 5261 A 送による。	Less than 20 mV p-p 未進
10	Insulation resistance 網載抗	A voltage of 500 V d.c. shall be applied 1 min after which measurement shall be made. d. C. 500V, 1分後	100 MΩ or more 以上
11	Dielectric strength 解理王	Trip current Between individual termi and frame/shaft 端子-ケース・軸面 Measuring frequency 50/60Hz 500V 原政 for 1 min 50/60 Hz 500V a. C. 1分間	nais without damage toparts. arcing or breakdown etc. 損傷、アーク、細胞が終 がないごと。
I ZX		1-股2 94.8.30 10000MENT NO.	CO., LTD. ONAL POTENTIOMETER Eで可変数語 K 5 0 2 1 - 2 (5//2) IDSG1. 8502781 Y. KANZA

	I tem	Conditions	Specifications
	項目	条 件	規 格
- 1	Tracking error 避避器	The voltage of 2 v r.m.s. shall be applied between terminal 1 and and between terminals 1 to 3 by measuring frequency at 1 kHz. The output voltage shall be measured between terminals 1 and 2 and between terminals 1 and 2 (for the 15 C and 25 C taper. the measurement shall be made between terminals 2 and 3 and between terminals 1 and 2 and 2 between terminals 1 and 2 and 3 and between terminals 1 and 2 and 2 between terminals 1 and 2 and 3 and between termi	e -80dB ~ 0dBET withi ± 3 dB以外
13	Electrostatic noise	The moving shaft shall be rotated at the specified speed. And the electrostatic noise shall be induced between terminals 1 and 2 or between terminals 2 and 3. **を指定の定さて回転させながら1ー2時子間、2ー3時子間で「東定する。 Rotational potentiometer s 「記述》 60°/特	Without noise 発生しないこと。
	·	•	·
14	Tao タップ	The resistance and the tolerance between nominal taps (Between taps 1 and 4.) 公子タップ間(1-4間)抵抗値および許容基は The end resistance between intermediate taps (Between taps 2 and 中間タップ(2-4間)残留抵抗値は	Q ± 30 1% or less of the nomina resistance. (Max. 500 g or less) 公将全抵抗菌の1%以下 (最大500以下とする)
	·	Tap position and tolerance タップ位置および部客差	± 3°

			•	· .	AUD	AL	PS E	LECTRIC CO., LTD.
					APPD I-BZE	CHKD. 1-数2	0SGO. 1-数2	TITLE ROTATIONAL POTENTIOMETER 回転可交換機器
<u>A</u> [95-6-8	川崎川崎	神持	姚神崎	94.6. 7.	94.6.06	94.6.03	DOCUMENT NO. 4 K 5 0 2 1 - 2 (6 (2)
SYMB	DATE	APPO	CHKD	DSGD		TIPE T	1 14 149	DSC1 8502781 Y KAN7A

31 Y. KANZA 94.04.25

	Ltem	Conditions	Specifications
	Item 用目	A #	想格
1	Solderability はんだ付け性	The terminals shall be stored at a temperature of 100°C with relative humidity of 100% for 16h after which mesurement to "Menisuco graph solderability" 温度100°C、湿度100%RHに16時間設置後、メニスコク*ラフ(230°C非活性ロシ*ン) にて利定する。	(1) Solder wetting time shall be 3 s or less. は九泛素相関 3. O材料(2) A new uniform coating of solder shall cover a minimum of 95% of the surface being immersed. は九泛光瀬原町の95%以上新しいは九泛大瀬原町の95%以上新しいは九泛て濡れていること。
2	Resistance to soldering heat は小心神神社	For procedures other than those specified below. refer to IEC Pub. 68-2-20. Test Tb Method 1A or 2. 下記のはがは JIS C 0050 (ただし部がたは1Aまたは2による)に準拠する。 Solder bath method デ 4-7での場合 Bit temperature	Change in total resistance is relative to the value before test 全抵抗論の変化は 初期値の ±5% Electrical characteristics shall be satisfied. Without distinct deformation in appearance. 電気的性能を満足すること。外間に著しい変化がないこと。
3	Resistance to flux penetration 耐フラックス上がり	時間 For test method, refer to page. "Test Method for Resistance to Flux Penetration." 調味方法は別様の「耐フラックス上外」調味方法」による。 Nominal board thickness : 1.6 mm	Electrical characteristic and characteristics shall be satisfied. 電気が対象。機能対象を表現しますること。
4	Dry heat 新知 主	The potentiometer shall be stored at a temperature 70±2°C for 240±8h in a thermostatic chamber. Then the potentiometer shall be maintained at standard atmospheric conditions for 1h after which measurements shall be made. For other procedures, refer to IEC Pub. 68-2-2. Test Bb. (Forced air circulation may be used.) ***********************************	

	•				AU	A	LPS E	LEC	TRIC CO.,	LTD.
					APPD 1-B2B	CHKD. 1-数2	1-8:2	TITLE	ROTATIONAL POTENT	IOMETER
SYMB	DATE	APPD	CHKD	DSGD	94.6. 7 佐藤	94.6.0	94.6.03	DOCUME	^{ent no} 4 K 5 0 2 1	- 2 (7//2)
									DSG1. 8502	781 y. kanzka 94. 04. 25

	item 項目	Conditions 4 #	Specifications 提格
	AC.	The potentiometer shall be stored at a temperature of -20±3 T for 240±4 h in a thermostatic chamber. Then the potentiometers hall be taken out of the chamber and its surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h. after which measurement shall be made.	Change in total resistance is relative to the value before test 全抵抗菌の変化は 初期値の ±20%
5	COId 翻練性	For other procedures, refer to IEC Pub. 68-2-1, Test Ab. (Forced air circulation may be used.) 温度-20±3での位置管中に240±4時間設置後とり出し、表面の水分をふきとり常温 常型中に1時間設置後端をする。 その他 JIS C 0020 に準拠する。	There shall be no daformetion or cracks of molded part. 成形部分に変彰。クラックがないこと。
6	Demo heat 歌灣性	The potentiometer shall be stored at a temperature of 60±2 で with relative humidity of 90% to 95% for 240±4 h in a thermostatic chamber. Then the potentiometer shall be taken out of the chamber and its surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h. after which measurement shall be made. For other procedures. refer to IEC Pub. 68-2-3. ②変60±2℃、浸皮90~95%の概念を浸料で240±4時間放置した後とり出し、表面の水分をみをとり常識化量中に1時間放置を設定する。	Change in total resistance is relative to the value before test 全抵抗菌の実化は初期菌の +25 % 1 nsulation resistance 20 MQ 以 総配抗 Noise Less than 電機管 100 mVP-p 未
	wite of	その他 JIS C 0022 応準拠する。	SERVICE TOO HIVD TO AN
	i		
-		The potentiometer shall be subjected to 5 successive change of temperature cycles, each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made.	Change in total resistant is relative to the value before test 全抵抗菌の実化は 初期後の ±20%
-		of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下記に示した過度サイクルを通信を行なう。 表面の水分をみきとり常常を持て1時間数量を設定する。 Insulation resistance	before test 全抵抗節の実化は 初期節の ±20% Clause 3.2.10 shall be satisfied.
	Change of	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下表に示した温度サイクルを通信を向行なう。 表面の水分を含まとり栄息性と1時間散温を設定する。 Temperature Duration 数面が Dielectric strength 再発圧	is relative to the value before test 全紙が卸力を付け では 地域の 生20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied.
?	Change of temperature 温度サイクル	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下表に示した過度サイクルを過去を行なう。 表面の水分を含さとり常温光度上に1時間を変化する。 Temperature Duration 第 度 知識的 Dielectric strength 開発主 1 -10±3 ℃ 30 min 分 Dielectric strength 開発主 Stradard atmospheric conditions 10 to 15 分 和pearance 外 最	is relative to the value before test 全統抗節の変化は 初期節の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no daform tion or cracks of molded part. 成形部分に変形、クラックが
7	temperature	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下形に示した過度サイクルを通信を行なう。 表面の水分をみきとり栄養性に1時間を登録さずる。 Temperature Duration 2 度 第一個 1 10±3 ℃ 30 min Dielectric strength 開発生 Stradard atmospheric 2 conditions 10 to 15 min 分 2 是 2 是 2 是 2 是 2 是 2 是 2 是 2 是 2 是 2	is relative to the value before test 全統論の実化は 初期節の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no daform tion or cracks of moided part.
7	temperature	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下表に示した理をサイクルを通信を行なう。表面の水分を多きとり常識性学に1時間を建設さる。 Insulation resistance に 2 conditions 10 to 15 分	is relative to the value before test 全統抗節の変化は 初期節の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no daform tion or cracks of molded part. 成形部分に変形、クラックが
7	temperature	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下表之下之事的分为是通历行之。表面的分分表多是少用证据中区1时间的重要。 Insulation resistance 是一个一个一个一个一个一个一个一个一个一个一个一个一个一个一个一个一个一个一个	is relative to the value before test 全統抗節の変化は 初期節の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no daform tion or cracks of molded part. 成形部分に変形、クラックが
?	temperature	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiometer shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. TRICTLUERTY/7月毛色区内47. *** TEMPERATURE DURATION *** Temperature Duration 2 min 2 min 2 min 2 conditions 10 to 15 min 2 min 2 min 3 70±2 °C 30 min 3 min 3 70±2 °C 30 min 3 min 4 conditions 10 to 15 min 2 min 2 min 2 min 3 70±2 °C 30 min 3 min 3 min 3 70±2 °C 30 min 3 min 4 min 4 min 4 min 5 min 5 min 5 min 5 min 6 min 6 min 6 min 6 min 6 min 6 min 7 min 6 min	is relative to the value before test 全転換面の実化は 初開館の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no daformation or cracks of moided part. 成形部分に変形、クラックが ないこと。
7	temperature	of temperature cycles. each as shown in table below. Then is surface moisture shall be removed. And then the potentiameter shall be subjected to standard atmospheric conditions for 1 h after which measurements shall be made. 下程元元之遗安之少米金融经历存之。 Temperature Duration	is relative to the value before test 全統論の実化は 初期値の ±20% Clause 3.2.10 shall be satisfied. 3.2.10項を満足すること。 Clause 3.2.11 shall be satisfied. 3.2.11項を満足すること。 There shall be no deform tion or cracks of molded part. 成形部分に変形、クラックが ないこと。

Item 項目	Conditions 2	Specifications 規格
8 Vibration 新版性	The moving contact shall be placed about half way (50%) in the angle of effective variable range. Only endurance conditioning by a frequency sweep shall be made. The entire frequency range. from 10 Hz to 55 Hz and return to 10 Hz. shall be transversed in 1 min. Amplitude (total excursion): 1.5 mm This motion shall be applied for a period of 2 h in each of 3 mutusly perpendicular axes (a total of 6 h). For other procedures, refer to IEC Pub. 68-2-6. 有效可要能的可能等50%的他是定题的子类要素,据例的综合10~55~10 Hz/分。全编码1.5mm, X·Y·Z为和区各2的局。	Without intermittent contacts or open circuiting between terminals. 各場子同て同意がないこと。 Rotational torque, and end stop shall not deviate from the previously specified value. 回転トルク、ストール学会支付開設措施を満足すること。
9 Shock 新記学性	Peak acceleration : 981 m/s²{100 G} 加速度 Duration of the pulse : 6 ms 作用编 Three successive shocks shall be applied in both directions of 3 mutually perpendicular axes (a total of 18 shocks). For other procedures, refe to IEC Pub. 68-2-27. 6配X回(計18回) 子の他 JIS C 0041 定準数する。	Without deformation of case or excessive looseness of teminals. 外観の変形および鑑子などの 著しいガタがないこと。
Resistance to 10 sulfuration 新城化生	The potentionmeter shall be stored at a H ₂ S density: 1ppm. tempreture: 40°C. relative humidity: 70% at 75%. for 96h in thermostatic chamber. after which measurments shall be made. H ₂ S 浓 度1ppm. 温度40°C 70~75%RHの情况296H政置後期記する.	Noise shall be relative to three times less to the value befor test. The attennuation and insertion loss shall not deviate from the previously specified value. 福助総合、は初期機合協の3合以下、また、最大減衰量、挿入損失は、初期機合協定すること。
	The moving shaft, without electrical load, shall be rotated	Change in total resistance
11 Endurance 動作耐久性	from end stop to the other and returned to its original position extended over 90% or more effective angle. This procedure constitutes 1 cycle. And the moving shaft shall be subjected to 600 cycles per hour. a total of 15000±200 cycles (5000 to 8000 continuous cycles for 24h) Measurements shall be made immediately after 5000 cycles. immediately after 10000 cycles. immediately after 10000 cycles. 無角音で触を600回/時(1往後1回とする)の速さて初回版 角度の90%以上にわたり1日連続5000~8000回。 合計 15000±200回 回版させる。 たたし、調整中5000回および10000回においても測定する。	is relative to the value before test. 全板が確の変化率は 初期値で対し ±15% Noise Less than 愛別雑音 47 MVD-D 未満

					ALPS ELECTRIC CO., LTD.						
					APPD 1-\$2\$	CHKD.	7	DSGD.	TITLE	回転形可変抵抗器	
SYMB	DATE	APPD	СНКО	DSGD	946. 7	94.6.0) 	94.6.03	DOCUME	MENT NO. 4 K 5 0 2 1 - 2 (9/12)	
<u> </u>	DATE									DSG1, 8502781 y. kanzal 94, 04, 25	

4. NOTE その他

4.1 The outside appearance

外額

1) The appearance is an easily changing color. Because this products case is made of the brass, that is an easily oxidizable metal.

本製品は外観部に黄銅材を使用しておりますので、酸化等により自然変色致します。

Without deformation distinct a flow striked damage change color, in appearance.

著しい傷、打痕、人為的変色等の無い事。

3) Pay attention shoud not catch up potentiometer in the naked fingers. It may cause a changing color apperance for sweat of fingers.

製品を素手で掴むと指の汗、水分等により変色する恐れがありますので、使用上ご注意下さい。

4) In operation, storage in high tempreture and humidity, and in corrosive gas, shall be avoided.

製品の保管は高温・高涅な場所、腐食性力。ス中は外観が変色する恐れがありますので避けるようお願いします。

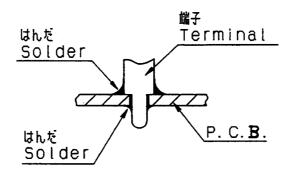
5) This product is made for a.c. use only. Please do not use d.c. voltage. 本部品はa.c. 専用ですのでd.c. での御使用はお遊け下さい。

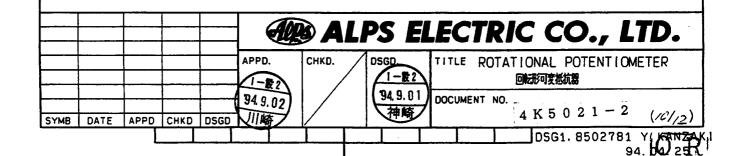
6) Caution for soldering

はんだ付け時のご注意事項

Please avoid soldering on upper surface of P.C.B. as shown.

図のようP. C. B. の上面にはんだをする配線はお避け下さい、





TEST METHOD FOR RESISTANCE TO FLUX PENETRATION 耐フラックス上がり試験方法

- 1. Materials
 - (1) Solder

Refer to IEC Pub. 68-2-20. Appendix B.

(2) Flux

GX-7- ASAHI CHEMICAL RESEARCH LABORATORY, MH-820V TAMURA KAKEN CO., LTD or an equivalent flux shall be used. The flux used shall consist 15% by weight of rosin. 1. 材料

(1) はんだ

JIS Z 3282に規定の63%Snはんだ(H63A)もしくは60% Snはんだ(H60A)

(2) フラックス

アサヒ化研製 GX-7, タムラ化研製 №1-820V もしくは それと同等品で、固形分濃度は重量比15%

Flux フラックス	Specific gravity 比重(20℃)
ASAHI CHEMICAL RESEARCH LABORATORY G	X-7 0. 823
TAMURA KAKEN CG.; LTD MH-8: タムラ化研製	20V 0. 824

(3) Printed wiring board

A board specified by NEMA(XPC) or it's equivalent board. Board shall be single-sided and its nominal thickness shall be specified in Clause "Resistance to flux penetration" with a copper foil thickness of $35\,\mu\mathrm{m}$. The position of mounting holes for test component shall correspond exactly to the terminal configuration so that terminals fit exactly into the holes. Hole size shall be as specified. If not specified, hole size shall exceed the diameter (or exterior dimensions in the case of non-circular terminals) of terminals by 0.2 mm to 0.4 mm. Unless otherwise specified, the conductor land size shall exceed the diameter (or dimensions) of holes by 2 mm to 4 mm.

(3) 基 板

JIS C 6485で規定されたプリント基板 (P.P)もしくはこれ と同等品(厚さは、「耐フラックス上がり」の条件に規定のもの35 μ m 片面網箔)に、部品のリード位置に対応して、特に指定のない場合は(リード形状 $+0.2\sim0.4$)mmの穴を あけたもの。 (取付穴寸法指定がある場合はそれによる。) パターンランドは特に指定がない場合は、 ø (リード外径 +2~4) mとする。

2. Test

(1) 'The printed wiring board specified in Clause 1 shall be socked only soldering side in the flux specified in Clause 1 for 3 to 5 s. The board shall then be taken out of the flux.

(2) The test components, its electrical characteristics and mechanical characteristics specified in this specification having already been measured, shall be inserted completely into the board as soon as the

board is removed from the flux.
(3) Either the flux bath method or the foaming method shall be used to apply flux a second time to the board. In either case, flux shall not come into contact with the component side surface and fluxing time shall be

3 to 4 s.

Note: After fluxing, if preheating is necessary before mounting, then the surface of the solder side shall be heated to 75 °C to 90 °C for 1 min or less.

- (4) Using an automatic soldering system or a hand dipping system, the board shall be soldered up to the component side surface (but the solder shall not come into contact with the component side) for 5±1 s at 250 ℃ to 260 °C.
- (5) The board shall be subjected to standard atmospheric conditions for 24 h or more after the soldering. Tests shall then be carried out as specified below;

Visual inspection of appearance

Measurement of characteristics as specified

2 . 試

- (1) 1項指定の基板を1.項指定のフラックス液中に基板の片面 を全面3~5秒間浸漬し、取り出す。
- 性能の初期測定を終了した部品をすみやかに、かつ、浮き がないようにマウントする。
- マウントした基板に、まず、基板上面スレスレまで指定の (3) フラックスを塗布する。(フラックス塗布は、発泡式または静止液中浸漬により3~4秒間行なう。)
 - 注:フラックス徳布後、プレヒートを行なう場合は、プレ ヒート時間は1分以内で基板のはんだ付面側の表面温 度が75~90℃になるようにする。
- その後自動はんだ付装置もしくは手ジャブにより、250~ (4) 260°Cのはんだ浴中で5±1秒間浸漬しはんだ付けする。 この時の浸渍深さは基板上面スレスレに達するように行な
- はんだ付けが終ったのち室温に24時間以上放置し、その後、 (5) 下記項目を調べる。 ① 目視による外観

② 規格に規定の性能の測定

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